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## TEST REPORT

Application No.:	SZEM1804003461CR (SGS SZ No.: T51810220173EM)	
Applicant:	DOUBLEEAGLE INDUSTRY (CHINA) LIMITED	
Address of Applicant:	Xingda Industrial Park, Chenghai District, Shantou City, Guangdong Province, China	
Manufacturer/ Supplier:	DOUBLEEAGLE INDUSTRY (CHINA) LIMITED	
Equipment Under Test (EUT	):	
EUT Name:	Building Blocks	
Item No.:	Please refer to section 2 🌲	
*	Please refer to section 2 of this report which indicates which item was actually tested and which were electrically identical.	
Country of Origin:	China	
Request Age Grading:	3+	
Standard(s) :	EN 301 489-1 V2.1.1	
	Final draft EN 301 489-3 V2.1.1	
Date of Receipt:	2018-05-04	
Date of Test:	2018-05-07 to 2018-05-10	
Date of Issue:	2018-05-10	
Test Result:	Pass*	

\* In the configuration tested, the EUT complied with the standards specified above.

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EU Declaration of Conformity and compliance with all relevant EU Directives.



#### Keny Xu EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.



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	Revision Record					
Version Chapter Date Modifier Rem						
01		2018-05-10		Original		

Authorized for issue by:		
	Gebin Sun	
	Gebin Sun /Project Engineer	-
	Evic Fu	
	Eric Fu /Reviewer	-



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### 2 Test Summary

Emission Part					
Item	Standard	Method	Requirement	Result	
Conducted Emissions at Mains Terminals (150kHz-30MHz)	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 55032:2015	Class B	Pass	
Radiated Emissions (30MHz-1GHz)	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 55032:2015	Class B	Pass	
Harmonic Current Emission	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-3-2:2014	Class A	Pass	
Voltage Fluctuations and Flicker	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-3-3:2013	Clause 5 of EN 61000-3-3	Pass	

mmunity Part					
Item	Standard	Method	Requirement	Result	
Electrostatic Discharge	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-4-2:2009	4kV Contact Discharge 8kV Air Discharge	Pass	
Electrical Fast Transients/Burst at Power Port	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-4-4:2012	1kV 5/50ns Tr/Td 5kHz Repetition Frequency	Pass	
Surge at Power Port	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-4-5:2014	1.2/50µs Tr/Td 1kV Line to Line 2kV Line to Ground	Pass	
Conducted Immunity at Power Port (150kHz-80MHz)	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-4-6:2014	3Vrms (emf),80%,1kHz Amp. Mod.	Pass	
Voltage Dips and Interruptions	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-4-11:2004	0 % UT for 0.5per 0 % UT for 1per 0 % UT for 250per 70 % UT for 25per UT is Supply Voltage	Pass	
Radiated Immunity (80MHz-6GHz)	EN 301 489-1 V2.1.1 Final draft EN 301 489-3 V2.1.1	EN 61000-4-3:2006 +A1:2008+A2:2010	3V/m, 80%, 1kHz Amp. Mod.	Pass	



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Remark:

Item No.: C51001W, C51002W, C51003W, C51004W, C51005W, C51006W, C51007W, C51008W, C51009W, C51010W, C51011W, C51012W, C51013W, C51014W, C51015W, C51016W, C51017W, C51018W, C51019W, C51020W, C51021W, C51022W, C51023W, C51024W, C51025W, C51026W, C51029W, C51030W, C51031W, C51032W, C51033W, C51034W, C51035W, C51036W, C51037W, C51038W, C51039W, C51040W, C52001W, C52002W, C52003W, C52004W, C52005W, C52006W, C52007W, C52008W, C52009W, C52010W, C52011W, C52012W, C52013W, C52014W, C52015W, C52016W, C52017W, C52018W, C52019W, C52010W, C52001W, C53001W, C53002W

Only the item C51004W was tested, since the electrical circuit design, layout, components used, internal wiring and functions were identical for all the above items, only different on decorations, colour and item No..



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## 4 General Information

### 4.1 Details of E.U.T.

	Power supply:	3.0V DC(1.5V x 2 "AA" Size Batteries) for TX	
		Rechargeable battery DC3.6V for RX	
	Cable:	USB Cable:60cm unshielded	
f	The highest working frequency(except RF modulator):	Less than 108MHz	
	Operating Frequency:	2.4GHz(2405MHz-2475MHz)	
	Channel number:	71	
	Modulation Type:	GFSK	
	Sample Type:	Portable production	
	Antenna Type:	Integral	
	Antenna Gain:	0dBi	

### 4.2 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
AC/DC Adapter	SGS	DC 5V	REF. No.SEA0500

### 4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty	
1	Conduction emission	3.45dB (9kHz to 150kHz)	
I	Conduction emission	3.0dB (150kHz to 30MHz)	
2	Dedicted emission	4.5dB (30MHz-1GHz)	
2	Radiated emission	4.8dB (1GHz-6GHz)	
3	Radiated Immunity	1.64dB	
4	Conducted Immunity	0.96dB	
5	ESD	6 %	
6	EFT (Electrical Fast Transients)	5 %	
7	Surge Immunity	5 %	
8	Voltage Dips and Interruptions	4 %	
9	Temperature test	1℃	
10	Humidity test	3%	
11	DC power test	0.5 %	



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### 4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

### 4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

### CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC

Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

### A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

#### • VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

#### • FCC – Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

### Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

### 4.6 Deviation from Standards

None

### 4.7 Abnormalities from Standard Conditions

None

### 4.8 Monitoring of EUT for All Immunity Test

Visual: Monitored the connection status of the EUT

Audio: None



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## 5 Equipment List

Conducted Emissions at Mains Terminals (150kHz-30MHz)						
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date	
Shielding Room	ChangZhou ZhongYu	GB-88	SEM001-06	2017-05-10	2020-05-09	
Measurement Software	AUDIX	e3 V5.4.1221d	N/A	N/A	N/A	
Coaxial Cable	SGS	N/A	SEM024-01	2017-07-13	2018-07-12	
LISN	Rohde & Schwarz	ENV216	SEM007-01	2017-09-27	2018-09-26	
LISN	ETS-LINDGREN	3816/2	SEM007-02	2018-04-02	2019-04-01	
EMI Test Receiver	Rohde & Schwarz	ESCI	SEM004-02	2018-04-02	2019-04-01	

Radiated Emissions (30MHz-1GHz)							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
3m Semi-Anechoic Chamber	ETS-LINDGREN	ETS-LINDGREN N/A SEM001-0		2017-08-05 2020-08-0			
Measurement Software	AUDIX	e3 V8.2014-6- 27	N/A	N/A	N/A		
Coaxial Cable	SGS	N/A	SEM025-01	2017-07-13	2018-07-12		
EMI Test Receiver	Agilent Technologies	N9038A	SEM004-05	2017-09-27	2018-09-26		
BiConiLog Antenna (26- 3000MHz)	ETS-LINDGREN	3142C	SEM003-01	2017-06-27	2020-06-26		
Pre-amplifier (0.1- 1300MHz)	Agilent Technologies	8447D	SEM005-01	2018-04-02	2019-04-01		

Voltage Fluctuations and Flicker							
Equipment Manufacturer		Model No	Inventory No	Cal Date	Cal Due Date		
AC Power Source	California Instruments	5001ix	SEM016-02	2018-04-13	2019-04-12		
Power Analyzer	California Instruments	PACS-1	SEM016-01	2018-04-13	2019-04-12		
Measurement Software	California Instruments	CTS 3.0 V3.2.0.6	N/A	N/A	N/A		

Electrostatic Discharge							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
ESD Ground Plane	SGS(3m*3m)	N/A	SEN006-01	N/A	N/A		
ESD Generator	TESEQ AG	NSG 437	SEM019-02	2018-04-16	2019-04-15		

Electrical Fast Transients/Burst at Power Port							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
Ultra Compact Simulator	EM TEST	UCS 500N7	SEM018-02	2018-04-13	2019-04-12		
Measurement Software	EM TEST	IEC CONTROL V6.0.1	N/A	N/A	N/A		

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Surge at Power Port							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
Ultra Compact Simulator	EM TEST	UCS 500N7	SEM018-02	2018-04-13	2019-04-12		
Measurement Software	EM TEST	IEC CONTROL V6.0.1	N/A	N/A	N/A		

Conducted Immunity at Power Port (150kHz-80MHz)						
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date	
Shielding Room	AUDIX	N/A	SEM001-08	2017-05-10	2020-05-10	
RF-Generator	SCHAFFNER	NSG 2070	SEM006-01	2017-09-27	2018-09-26	
Coupling/Decoupling Network	SCHAFFNER	CDN M016	SEM007-03	2018-05-07	2019-05-06	
Conditioning Amplifier	Brüel & Kjaer	2690-OS2	SEM005-10	2018-04-20	2019-04-19	
Audio Analyzer	Rohde & Schwarz	UPV	SEM008-03	2017-09-27	2018-09-26	

Voltage Dips and Interruptions							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
Ultra Compact Simulator	EM TEST	UCS 500N7	SEM018-02	2018-04-13	2019-04-12		
Measurement Software	EM TEST	IEC CONTROL V6.0.1	N/A	N/A	N/A		

Radiated Immunity (80MHz-6GHz)								
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
Fully-Anechoic Chamber 2	Chang Zhou Zhong Shuo	854	SEM001-05	2017-05-10	2020-05-09			
Measurement Software	Rohde & Schwarz	EMC32 V9.25.00	N/A	N/A	N/A			
Signal Generator	Rohde & Schwarz	SMB100A	SEM006-11	2018-04-02	2019-04-01			
Broadband Amplifier(80MHz-1GHz)	Rohde & Schwarz	BBA150- BC250	SEM005-12	2017-09-27	2018-09-26			
Broadband Amplifier(800MHz- 3GHz)	Rohde & Schwarz	BBA150-D110	SEM005-13	2018-04-02	2019-04-01			
Broadband Amplifier(2.5GHz-6GHz)	Rohde & Schwarz	BBA150-E60	SEM005-16	2018-04-13	2019-04-12			
Power Sensor	Rohde & Schwarz	NRP-Z91	SEM009-09	2018-04-02	2019-04-01			
Stacked LogPer Broadband Antenna(70MHz-10GHz)	Schwarzbeck	STLP 9129	SEM003-25	N/A	N/A			
Amplifier(10kHz- 250MHz)	Amplifier Research	75A250A	SEM005-11	2018-04-02	2019-04-01			
Universal Radio Communication Tester	Rohde & Schwarz	CMU 200	SEM010-01	2017-09-27	2018-09-26			



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Universal Radio Communication Tester	Rohde & Schwarz	CMW 500	SEM010-03	2018-04-02	2019-04-01
Conditioning Amplifier	Brüel & Kjaer	2690-OS2	SEM005-10	2018-04-20	2019-04-19
Mouth Simulator	Brüel & Kjaer	4227	SEM017-01	2018-04-10	2019-04-09
Signal Source	Brüel & Kjaer	4231	SEM017-02	2018-04-14	2019-04-13
Audio Analyzer	Rohde & Schwarz	UPV	SEM008-03	2017-09-27	2018-09-26

General used equipment							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-03	2017-09-29	2018-09-28		
Humidity/ Temperature Indicator	Shanghai Meteorological Industry Factory	ZJ1-2B	SEM002-04	2017-09-29	2018-09-28		
Humidity/ Temperature Indicator	Mingle	N/A	SEM002-08	2017-09-29	2018-09-28		
Barometer	Changchun Meteorological Industry Factory	DYM3	SEM002-01	2018-04-08	2019-04-07		



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## 6 Emission Test Results

### 6.1 Conducted Emissions at Mains Terminals (150kHz-30MHz)

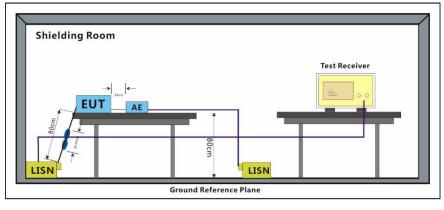
Test Requirement: Test Method: Frequency Range: Limit:	EN 301 489-1 V2.1.1 EN 55032:2015 150kHz to 30MHz
0.15M-0.5MHz	66dB( $\mu$ V)-56dB( $\mu$ V) quasi-peak, 56dB( $\mu$ V)-46dB( $\mu$ V) average
0.5M-5MHz	56dB(μV) quasi-peak, 46dB(μV) average
5M-30MHz	60dB(µV) quasi-peak, 50dB(µV) average
Detector:	Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

### 6.1.1 E.U.T. Operation

Operating Environment:

Temperature:	22 °C	Humidity:	53.9 % RH	Atmospheric Pressure:	1020	mbar
Pretest these modes to find the worst case:	b:Charging mo c:Idle mode,ke	•		JT in charging mode.		
The worst case for final test:	b:Charging mo	ode,Keep the	battery of the EL	JT in charging mode.		

### 6.1.2 Test Setup Diagram



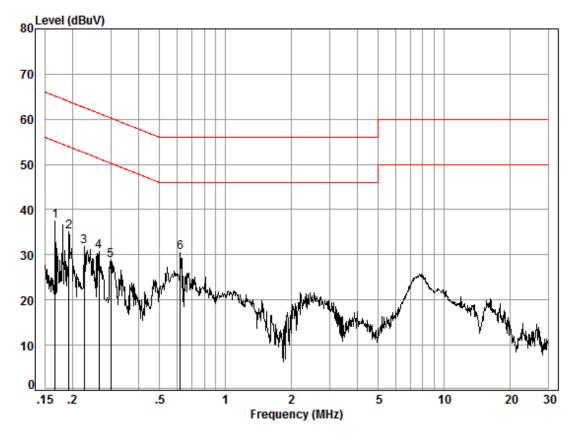
#### 6.1.3 Measurement Data

An initial pre-scan was performed with peak detector.Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.



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Mode:b; Line:Live Line



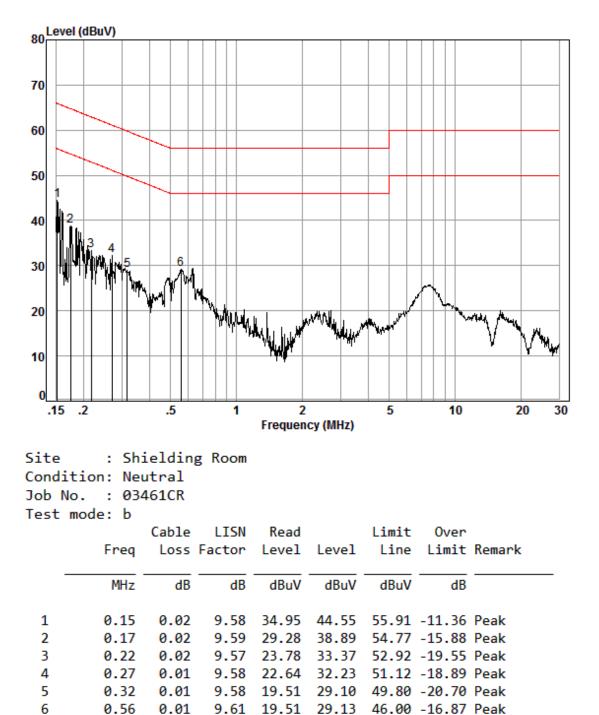
Site : Shielding Room Condition: Line Job No. : 03461CR Test mode: b

		Cable	LISN	Read		Limit	0ver	
	Freq	Loss	Factor	Level	Level	Line	Limit	Remark
	MHz	dB	dB	dBuV	dBuV	dBuV	dB	
1	0.17	0.02	9.52	27.90	37.44	55.12	-17.68	Peak
2	0.19	0.02	9.50	25.68	35.20	53.93	-18.73	Peak
3	0.23	0.02	9.51	22.37	31.90	52.61	-20.71	Peak
4	0.26	0.01	9.51	21.28	30.80	51.29	-20.49	Peak
5	0.30	0.01	9.51	19.23	28.75	50.28	-21.53	Peak
6	0.62	0.02	9.52	20.99	30.53	46.00	-15.47	Peak



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Mode:b; Line:Neutral Line





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### 6.2 Radiated Emissions (30MHz-1GHz)

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 55032:2015
Frequency Range:	30MHz to 1GHz
Measurement Distance:	3m
Limit:	
30MHz-230MHz	40 dB(μV/m) quasi-peak
230MHz-1GHz	47 dB(μV/m) quasi-peak
Detector:	Peak for pre-scan (120kHz resolution bandwidth) 30M to 1000MHz

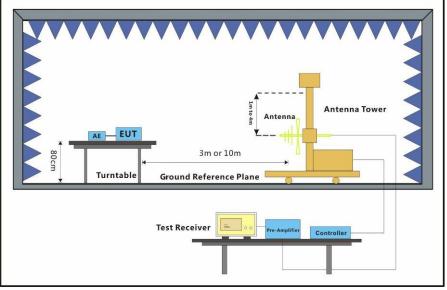
### 6.2.1 E.U.T. Operation

Operating Environment:

Temperature:	23.6 °C	Humidity:	53.2 % RH	Atmospheric Pressure:	1020	mbar			
Pretest these	a:Wireless mode,Keep the EUT pairing and working at high channel.								
modes to find	b:Charging mode,Keep the battery of the EUT in charging mode.								
the worst case:	c:Idle mode,keep EUT standby.								
The worst case a:Wireless mode,Keep the EUT pairing and working at high chann									

The worst case for final test:

#### 6.2.2 Test Setup Diagram



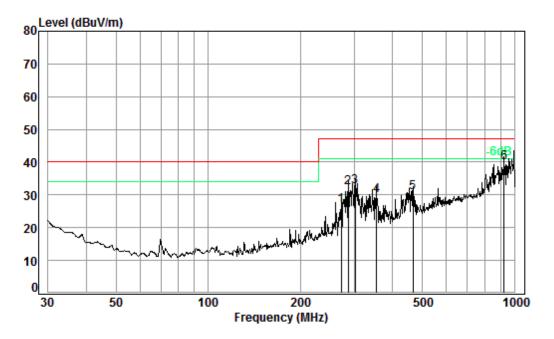
#### 6.2.3 Measurement Data

An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.



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#### Mode:a; Polarization:Horizontal



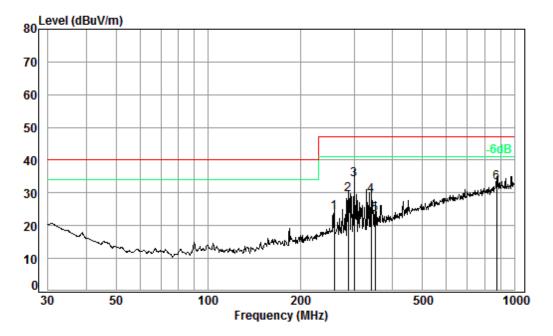
#### Condition: 3m HORIZONTAL Job No. : 03461CR

	: a Freq			Preamp Factor				Over Limit
-	MHz	dB		dB		dBuV/m		dB
1 2 3 4 5 6 pp	272.28 286.98 302.48 354.18 465.60 925.76	1.84 1.91 2.07 2.47	19.09 19.68 21.22 23.90	27.54 27.54 27.55 27.65 27.83 26.99	38.85 38.51 34.25 32.15	32.24 32.55 29.89 30.69	47.00 47.00 47.00 47.00	-14.76 -14.45 -17.11 -16.31



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Mode:a; Polarization:Vertical



#### Condition: 3m VERTICAL Job No. : 03461CR

	: a							
		Cable	Ant	Preamp	Read		Limit	0ver
	Freq	Loss	Factor	Factor	Level	Level	Line	Limit
	MHz	dB	dB/m	dB	dBuV	dBuV/m	dBuV/m	dB
1	258.33	1.71	19.08	27.54	30.85	24.10	47.00	-22.90
2	286.98	1.84	19.09	27.54	36.02	29.41	47.00	-17.59
3 pp	299.32	1.90	19.57	27.54	40.14	34.07	47.00	-12.93
4	340.78	2.03	20.84	27.62	34.03	29.28	47.00	-17.72
5	350.48	2.06	21.11	27.64	27.94	23.47	47.00	-23.53
6	875.25	3.51	29.49	27.16	27.28	33.12	47.00	-13.88



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### 6.3 Harmonic Current Emission

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-3-2:2014
Frequency Range:	100Hz to 2kHz

There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2:2014.

For further details, please refer to Clause 7 of EN 61000-3-2 which states:

"For the following categories of equipment, limits are not specified in this standard.- equipment with a rated power of 75W or less, other than lighting equipment."



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### 6.4 Voltage Fluctuations and Flicker

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-3-3:2013

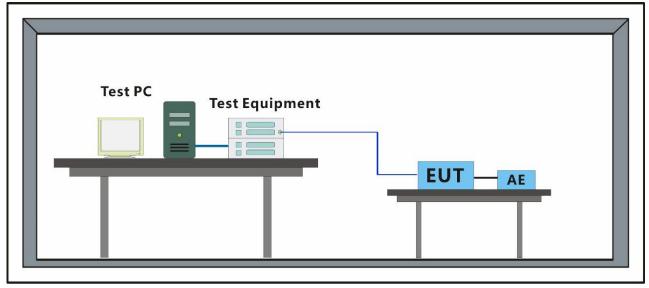
### 6.4.1 E.U.T. Operation

Operating Environment:

Temperature:24.6 °CHumidity:55.3 % RHAtmospheric Pressure:1020mbarPretest these<br/>modes to find<br/>the worst case:b:Charging mode,Keep the battery of the EUT in charging mode.<br/>c:Idle mode,keep EUT standby.c:Idle mode,keep EUT standby.

The worst case b:Charging mode,Keep the battery of the EUT in charging mode. for final test:

#### 6.4.2 Test Setup Diagram



6.4.3 Measurement Data



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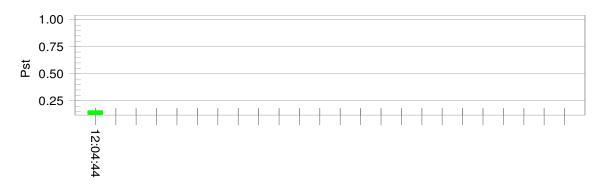
Mode:b

**Test Result: Pass** 

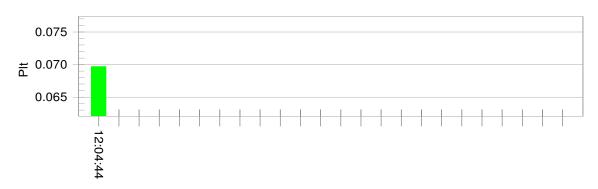
Status: Test Completed

Psti and limit line

**European Limits** 



#### Plt and limit line



#### Parameter values recorded during the test: Vrms at the end of test (Volt): 230.20

vrms at the end of test (volt):	230.20			
Highest dt (%):	0.00	Test limit (%):	3.30	Pass
Time(mS) > dt:	0.0	Test limit (mS):	500.0	Pass
Highest dc (%):	0.00	Test limit (%):	3.30	Pass
Highest dmax (%):	0.00	Test limit (%):	4.00	Pass
Highest Pst (10 min. period):	0.160	Test limit:	1.000	Pass



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## 7 Immunity Test Results

### 7.1 Performance Criteria Description in EN 301 489-1 V2.1.1

Performance criteria for continuous phenomena applied to transmitters and receivers	During and after the test, the equipment shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer when the equipment is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance. During the test, the EUT shall not unintentionally transmit or change its actual operating state and stored data. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.
Performance criteria for transient phenomena applied to transmitters and receivers	<ul> <li>For surges applied to symmetrically operated wired network ports intended to be connected directly to outdoor lines the following criteria applies:</li> <li>For products with only one symmetrical port intended for connection to outdoor lines, loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. A SW reboot is not allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.</li> </ul>
	<ul> <li>For products with more than one symmetrical port intended for connection to outdoor lines, loss of function on the port under test is allowed, provided the function is self-recoverable. A SW reboot is not allowed. Information stored in non-volatile memory, or protected by a battery backup, shall not be lost.</li> <li>For all other ports the following applies:</li> </ul>
	• After the test, the equipment shall continue to operate as intended. No degradation of performance or loss of function is allowed below a permissible performance level specified by the manufacturer, when the equipment is used as intended. In some cases this permissible performance level may be replaced by a permissible loss of performance.
	• During the EMC exposure to an electromagnetic phenomenon, a degradation of performance is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) or stored data is allowed.
	• If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect from the equipment if used as intended.
Performance criteria for equipment which does not provide a continuous communication link	For radio equipment which does not provide a continuous communication link, the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests. The performance specification shall be included in the product description and documentation.



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Performance criteria for ancillary equipment tested on a stand alone basis	If ancillary equipment is intended to be tested on a stand alone basis, the manufacturer shall declare, for inclusion in the test report, his own specification for an acceptable level of performance or degradation of performance during and/or after the immunity tests. The performance specification shall be included in the product description and documentation.
--	--

### 7.2 Performance Criteria Description in Final Draft EN 301 489-3 V2.1.1

Criteria	During Test	After Test
	Operate as intended	Operate as intended
	No loss of function	No loss of function
A	No unintentional responses	No degradation of performance
		No loss of stored data or user programmable functions
	May show loss of function	Operate as intended
в	No unintentional responses	Lost function(s) shall be self-recoverable
В		No degradation of performance
		No loss of stored data or user programmable functions

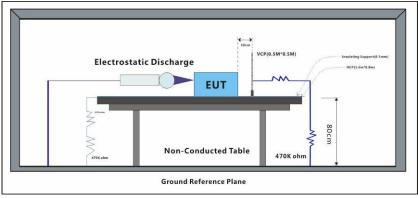


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### 7.3 Electrostatic Discharge

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-4-2:2009
Performance Criterion:	В
Discharge Impedance:	330Ω/150pF
Number of Discharge:	Minimum 10 times at each test point
Discharge Mode:	Single Discharge
Discharge Period:	1 second minimum

#### 7.3.1 Test Setup Diagram



#### 7.3.2 E.U.T. Operation

**Operating Environment:** 

Temperature:24.4 °CHumidity:45 % RHAtmospheric Pressure:1020 mbarTest mode:a:Wireless mode,Keep the EUT pairing and working at high channel.<br/>b:Charging mode,Keep the battery of the EUT in charging mode.<br/>c:Idle mode,keep EUT standby.

#### 7.3.3 Test Results:

Observations: Test Point:

- 1. All insulated enclosure and seams.
- 2. All accessible metal parts of the enclosure.

3			[	
Discharge type	Level (kV)	Polarity	Test Point	Result / Observations
Air Discharge	2,4,8	+	1	А
Air Discharge	2,4,8	-	1	А
Contact Discharge	4	+	2	А
Contact Discharge	4	-	2	A
Horizontal Coupling	4	+	3	А
Horizontal Coupling	4	-	3	А
Vertical Coupling	4	+	3	A
Vertical Coupling	4	-	3	A

#### **Results:**

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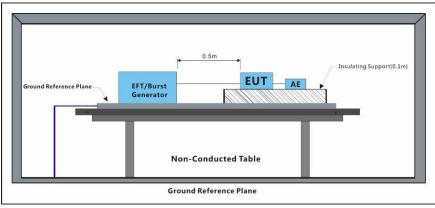


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### 7.4 Electrical Fast Transients/Burst at Power Port

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-4-4:2012
Performance Criterion:	В
Repetition Frequency:	5kHz
Burst Period:	300ms

### 7.4.1 Test Setup Diagram



### 7.4.2 E.U.T. Operation

Operating Environment:

Temperature:24.6 °CHumidity:55.5 % RHAtmospheric Pressure:1020 mbarTest mode:b:Charging mode,Keep the battery of the EUT in charging mode.

#### 7.4.3 Test Results:

Test Line	Level (kV)	Polarity	CDN/Clamp	Result / Observations
AC power port	1	+	CDN	А
AC power port	1	-	CDN	A

#### **Results:**

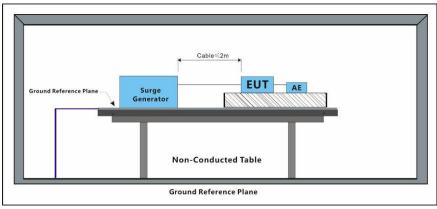


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### 7.5 Surge at Power Port

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-4-5:2014
Performance Criterion:	В
Interval:	60s between each surge
No. of surges:	5 positive, 5 negative at 0°, 90°, 180°, 270°.
T . O . D'	

### 7.5.1 Test Setup Diagram



### 7.5.2 E.U.T. Operation

Operating Environment:

Temperature:24.6 °CHumidity:55.5 % RHAtmospheric Pressure:1020 mbarTest mode:b:Charging mode,Keep the battery of the EUT in charging mode.

### 7.5.3 Test Results:

Test Line	Level (kV)	Polarity	Phase (deg)	Result / Observations
L-N	1	+	0°	А
L-N	1	-	0°	А
L-N	1	+	90°	А
L-N	1	-	90°	А
L-N	1	+	180°	А
L-N	1	-	180°	A
L-N	1	+	270°	A
L-N	1	-	270°	А

### **Results:**

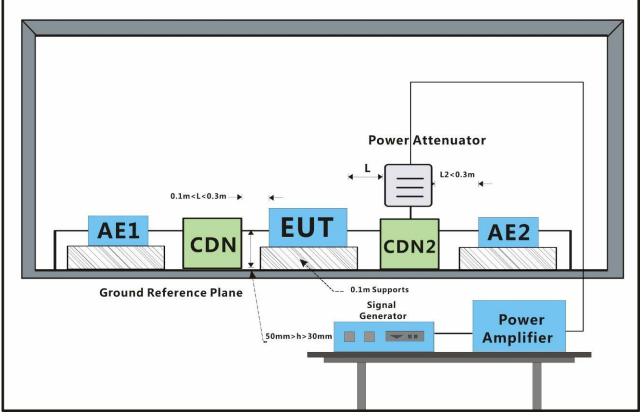


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### 7.6 Conducted Immunity at Power Port (150kHz-80MHz)

	•
Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-4-6:2014
Performance Criterion:	A
Frequency Range:	0.15MHz to 80MHz
Modulation:	80%, 1kHz Amplitude Modulation
Step Size	1%
Tost Satun Diagram	

### 7.6.1 Test Setup Diagram



#### 7.6.2 E.U.T. Operation

**Operating Environment:** 

Temperature:24.6 °CHumidity:55.1 % RHAtmospheric Pressure:1020mbarTest mode:b:Charging mode,Keep the battery of the EUT in charging mode.

#### 7.6.3 Test Results:

Cable port	Level (Vrms)	CDN/Clamp	Dwell time	Result / Observations
AC power port	3	CDN	2s	А

#### **Results:**

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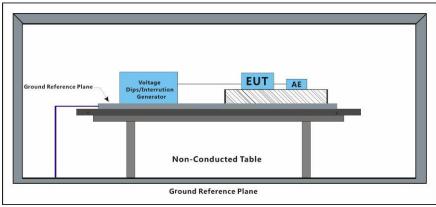


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### 7.7 Voltage Dips and Interruptions

	-
Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-4-11:2004
Performance Criterion:	0% of UT (Supply Voltage) for 0.5 Periods:B; 0% of UT for 250 Periods:C; 70 % of UT for 25 Periods:C
No. of Dips / Interruptions:	3 per Level
Time between dropout	10s

### 7.7.1 Test Setup Diagram



### 7.7.2 E.U.T. Operation

**Operating Environment:** 

Temperature:24.6 °CHumidity:55 % RHAtmospheric Pressure:1020 mbarTest mode:b:Charging mode,Keep the battery of the EUT in charging mode.

### 7.7.3 Test Results:

Level % UT	Phase (deg)	Duration	No. of Dips / Interruptions	Result / Observations
0	0°	0.5 Cycles	3	А
0	180°	0.5 Cycles	3	А
0	0°	250 Cycles	3	В
0	180°	250 Cycles	3	В
70	0°	25 Cycles	3	А
70	180°	25 Cycles	3	А

#### **Results:**

A: No degradation in the performance of the EUT was observed.

B: The EUT stops charging during the test, but can recover automatically after the test.

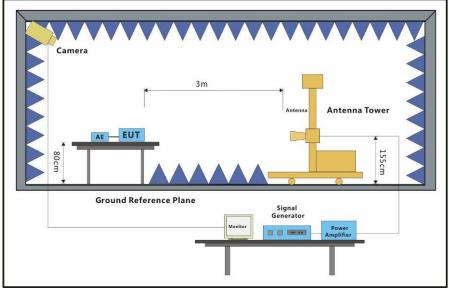


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### 7.8 Radiated Immunity (80MHz-6GHz)

Test Requirement:	EN 301 489-1 V2.1.1
Test Method:	EN 61000-4-3:2006 +A1:2008+A2:2010
Performance Criterion:	Α
Frequency Range:	80MHz to 6GHz
Antenna Polarisation:	Vertical and Horizontal
Modulation:	1kHz,80% Amp. Mod,1% increment

### 7.8.1 Test Setup Diagram



#### 7.8.2 E.U.T. Operation

**Operating Environment:** 

Temperature:23 °CHumidity:56 % RHAtmospheric Pressure:1020 mbarTest mode:a:Wireless mode,Keep the EUT pairing and working at high channel.<br/>b:Charging mode,Keep the battery of the EUT in charging mode.<br/>c:Idle mode,keep EUT standby.

#### 7.8.3 Test Results:

Frequency	Level (V/m)	EUT Face	Dwell time	Result / Observations
80MHz-6GHz	3	Front	2s	А
80MHz-6GHz	3	Back	2s	А
80MHz-6GHz	3	Left	2s	А
80MHz-6GHz	3	Right	2s	А
80MHz-6GHz	3	Тор	2s	А
80MHz-6GHz	3	Underside	2s	А

#### **Results:**

A: No degradation in the performance of the EUT was observed.



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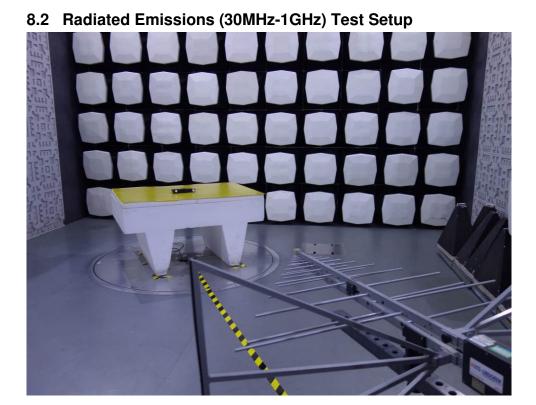
### 8 Photographs

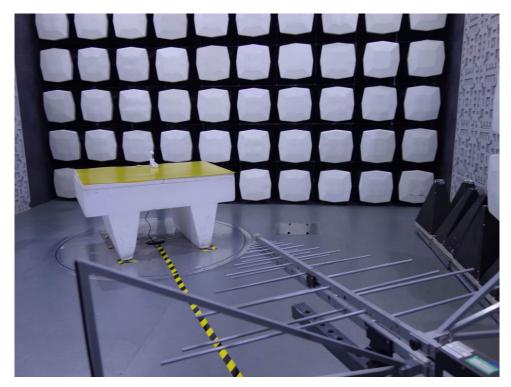
8.1 Conducted Emissions at Mains Terminals (150kHz-30MHz) Test Setup





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### 8.3 Voltage Fluctuations and Flicker Test Setup





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### 8.4 Electrostatic Discharge Test Setup

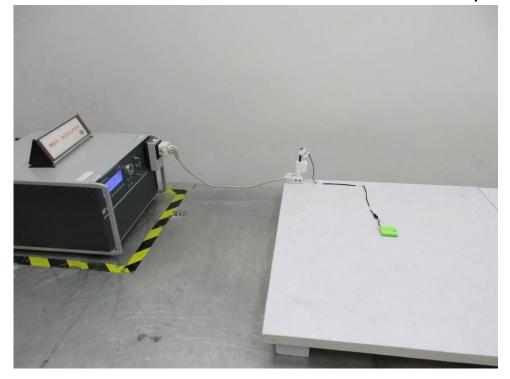




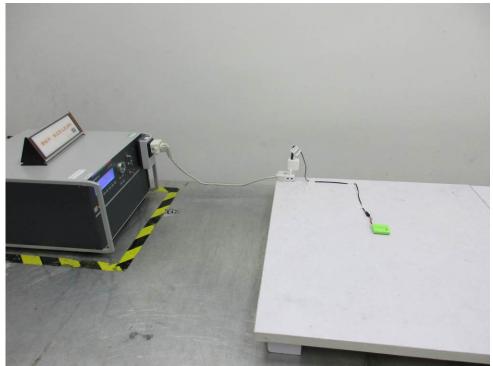


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### 8.5 Electrical Fast Transients/Burst at Power Port Test Setup



8.6 Surge at Power Port Test Setup



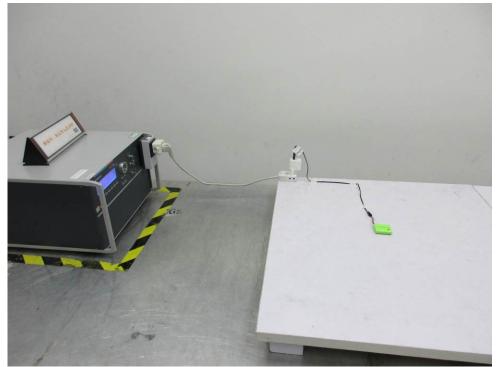


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8.7 Conducted Immunity at Power Port (150kHz-80MHz) Test Setup



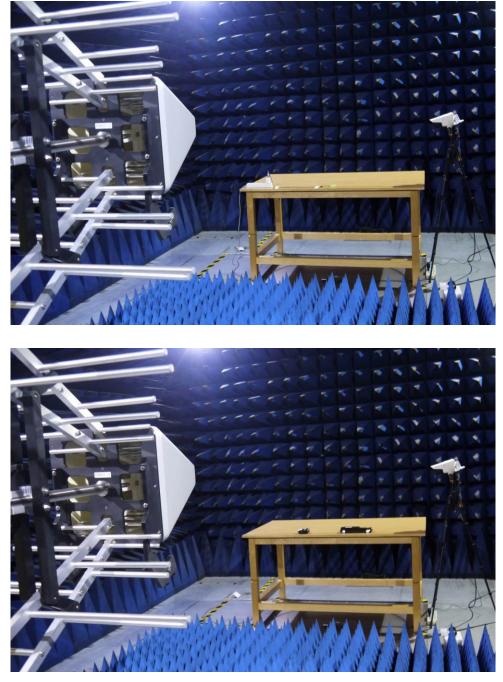
8.8 Voltage Dips and Interruptions Test Setup





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### 8.9 Radiated Immunity (80MHz-6GHz) Test Setup



8.10 EUT Constructional Details (EUT Photos) Refer to Appendix A - Photographs of EUT Constructional Details for SZEM1804003461CR.

- End of the Report -